# E·XFL

## NXP USA Inc. - KMPC8347VRAGD Datasheet



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#### Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

## Applications of **Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

### Details

Product Status	Obsolete
Core Processor	PowerPC e300
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	400MHz
Co-Processors/DSP	-
RAM Controllers	DDR
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (2)
SATA	-
USB	USB 2.0 + PHY (2)
Voltage - I/O	2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	620-BBGA Exposed Pad
Supplier Device Package	620-HBGA (29x29)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/kmpc8347vragd

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



#### Overview

- Up to four physical banks (chip selects), each bank up to 1 Gbyte independently addressable
- DRAM chip configurations from 64 Mbits to 1 Gbit with  $\times 8/\times 16$  data ports
- Full error checking and correction (ECC) support
- Support for up to 16 simultaneous open pages (up to 32 pages for DDR2)
- Contiguous or discontiguous memory mapping
- Read-modify-write support
- Sleep-mode support for SDRAM self refresh
- Auto refresh
- On-the-fly power management using CKE
- Registered DIMM support
- 2.5-V SSTL2 compatible I/O for DDR1, 1.8-V SSTL2 compatible I/O for DDR2
- Dual three-speed (10/100/1000) Ethernet controllers (TSECs)
  - Dual controllers designed to comply with IEEE 802.3<sup>TM</sup>, 802.3u<sup>TM</sup>, 820.3x<sup>TM</sup>, 802.3z<sup>TM</sup>, 802.3ac<sup>TM</sup> standards
  - Ethernet physical interfaces:
    - 1000 Mbps IEEE Std. 802.3 GMII/RGMII, IEEE Std. 802.3z TBI/RTBI, full-duplex
    - 10/100 Mbps IEEE Std. 802.3 MII full- and half-duplex
  - Buffer descriptors are backward-compatible with MPC8260 and MPC860T 10/100 programming models
  - 9.6-Kbyte jumbo frame support
  - RMON statistics support
  - Internal 2-Kbyte transmit and 2-Kbyte receive FIFOs per TSEC module
  - MII management interface for control and status
  - Programmable CRC generation and checking
- PCI interface
  - Designed to comply with PCI Specification Revision 2.3
  - Data bus width:
    - 32-bit data PCI interface operating at up to 66 MHz
  - PCI 3.3-V compatible
  - PCI host bridge capabilities
  - PCI agent mode on PCI interface
  - PCI-to-memory and memory-to-PCI streaming
  - Memory prefetching of PCI read accesses and support for delayed read transactions
  - Posting of processor-to-PCI and PCI-to-memory writes
  - On-chip arbitration supporting five masters on PCI
  - Accesses to all PCI address spaces
  - Parity supported
  - Selectable hardware-enforced coherency

**Power Characteristics** 

	Core Frequency (MHz)	CSB Frequency (MHz)	Typical at T <sub>J</sub> = 65	Typical <sup>2,3</sup>	Maximum <sup>4</sup>	Unit
TBGA	333	333	2.0	3.0	3.2	W
		166	1.8	2.8	2.9	W
	400	266	2.1	3.0	3.3	W
		133	1.9	2.9	3.1	W
	450	300	2.3	3.2	3.5	W
		150	2.1	3.0	3.2	W
	500	333	2.4	3.3	3.6	W
		166	2.2	3.1	3.4	W
	533	266	2.4	3.3	3.6	W
		133	2.2	3.1	3.4	W
	667 <sup>5,6</sup>	333	3.5	4.6	5	W

 Table 4. MPC8347EA Power Dissipation<sup>1</sup> (continued)

<sup>1</sup> The values do not include I/O supply power (OV<sub>DD</sub>, LV<sub>DD</sub>, GV<sub>DD</sub>) or AV<sub>DD</sub>. For I/O power values, see Table 5.

<sup>2</sup> Typical power is based on a voltage of  $V_{DD} = 1.2$  V, a junction temperature of  $T_J = 105$  °C, and a Dhrystone benchmark application.

<sup>3</sup> Thermal solutions may need to design to a value higher than typical power based on the end application, T<sub>A</sub> target, and I/O power.

<sup>4</sup> Maximum power is based on a voltage of V<sub>DD</sub> = 1.2 V, worst case process, a junction temperature of T<sub>J</sub> = 105°C, and an artificial smoke test.

<sup>5</sup> Typical power is based on a voltage of  $V_{DD}$  = 1.3 V, a junction temperature of  $T_J$  = 105°C, and a Dhrystone benchmark application.

<sup>6</sup> Maximum power is based on a voltage of  $V_{DD}$  = 1.3 V, worst case process, a junction temperature of  $T_J$  = 105°C, and an artificial smoke test.



Table 20. DDR and DDR2 SDRAM Output AC Timing Specifications (continued)

At recommended operating conditions with  $GV_{DD}$  of (1.8 or 2.5 V) ± 5%.

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
266 MHz		1100	_		
200 MHz		1200	—		
MDQS preamble start	t <sub>DDKHMP</sub>	$-0.5\times t_{MCK}-0.6$	$-0.5\times t_{MCK}+0.6$	ns	6
MDQS epilogue end	t <sub>DDKHME</sub>	-0.6	0.6	ns	6

Notes:

- The symbols for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t<sub>(first two letters of functional block)(reference)(state)(signal)(state)</sub> for outputs. Output hold time can be read as DDR timing (DD) from the rising or falling edge of the reference clock (KH or KL) until the output goes invalid (AX or DX). For example, t<sub>DDKHAS</sub> symbolizes DDR timing (DD) for the time t<sub>MCK</sub> memory clock reference (K) goes from the high (H) state until outputs (A) are set up (S) or output valid time. Also, t<sub>DDKLDX</sub> symbolizes DDR timing (DD) for the time t<sub>MCK</sub> memory clock reference (K) goes low (L) until data outputs (D) are invalid (X) or data output hold time.
  </sub>
- 2. All MCK/ $\overline{MCK}$  referenced measurements are made from the crossing of the two signals ±0.1 V.
- 3. ADDR/CMD includes all DDR SDRAM output signals except MCK/MCK, MCS, and MDQ/MECC/MDM/MDQS. For the ADDR/CMD setup and hold specifications, it is assumed that the clock control register is set to adjust the memory clocks by 1/2 applied cycle.
- 4. t<sub>DDKHMH</sub> follows the symbol conventions described in note 1. For example, t<sub>DDKHMH</sub> describes the DDR timing (DD) from the rising edge of the MCK(n) clock (KH) until the MDQS signal is valid (MH). t<sub>DDKHMH</sub> can be modified through control of the DQSS override bits in the TIMING\_CFG\_2 register and is typically set to the same delay as the clock adjust in the CLK\_CNTL register. The timing parameters listed in the table assume that these two parameters are set to the same adjustment value. See the MPC8349EA PowerQUICC II Pro Integrated Host Processor Family Reference Manual for the timing modifications enabled by use of these bits.
- 5. Determined by maximum possible skew between a data strobe (MDQS) and any corresponding bit of data (MDQ), ECC (MECC), or data mask (MDM). The data strobe should be centered inside the data eye at the pins of the microprocessor.
- 6. All outputs are referenced to the rising edge of MCK(n) at the pins of the microprocessor. Note that t<sub>DDKHMP</sub> follows the symbol conventions described in note 1.

Figure 6 shows the DDR SDRAM output timing for the MCK to MDQS skew measurement (t<sub>DDKHMH</sub>).



Figure 6. Timing Diagram for t<sub>DDKHMH</sub>



#### Ethernet: Three-Speed Ethernet, MII Management

## Table 28. MII Receive AC Timing Specifications (continued)

At recommended operating conditions with  $LV_{DD}/OV_{DD}$  of 3.3 V  $\pm$  10%.

Parameter/Condition	Symbol <sup>1</sup>	Min	Тур	Max	Unit
RX_CLK clock rise (20%–80%)	t <sub>MRXR</sub>	1.0	—	4.0	ns
RX_CLK clock fall time (80%–20%)	t <sub>MRXF</sub>	1.0	—	4.0	ns

## Note:

The symbols for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t<sub>(first two letters of functional block)(reference)(state)(signal)(state)</sub> for outputs. For example, t<sub>MRDVKH</sub> symbolizes MII receive timing (MR) with respect to the time data input signals (D) reach the valid state (V) relative to the t<sub>MRX</sub> clock reference (K) going to the high (H) state or setup time. Also, t<sub>MRDXKL</sub> symbolizes MII receive timing (CD) went invalid (X) relative to the t<sub>MRX</sub> clock reference (K) going to the low (L) state or hold time. In general, the clock reference symbol is based on three letters representing the clock of a particular function. For example, the subscript of t<sub>MRX</sub> represents the MII (M) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
</sub>

Figure 12 provides the AC test load for TSEC.



Figure 12. TSEC AC Test Load

Figure 13 shows the MII receive AC timing diagram.



Figure 13. MII Receive AC Timing Diagram

## 8.2.3 TBI AC Timing Specifications

This section describes the TBI transmit and receive AC timing specifications.



Local Bus



Figure 23. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 2 (DLL Enabled)



Figure 24. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 2 (DLL Bypass Mode)







Figure 26. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 4 (DLL Enabled)

## 11 JTAG

This section describes the DC and AC electrical specifications for the IEEE Std. 1149.1 (JTAG) interface of the MPC8347EA.

## **11.1 JTAG DC Electrical Characteristics**

Table 40 provides the DC electrical characteristics for the IEEE Std. 1149.1 (JTAG) interface of the MPC8347EA.

Table 40. JTAG Interface DC Electrical Characteristi	cs
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Parameter	Symbol	Condition	Min	Мах	Unit
Input high voltage	V <sub>IH</sub>	—	OV <sub>DD</sub> - 0.3	OV <sub>DD</sub> + 0.3	V
Input low voltage	V <sub>IL</sub>	—	-0.3	0.8	V
Input current	I <sub>IN</sub>	—	-	±5	μA
Output high voltage	V <sub>OH</sub>	I <sub>OH</sub> = -8.0 mA	2.4	—	V



JTAG

## Table 41. JTAG AC Timing Specifications (Independent of CLKIN)<sup>1</sup> (continued)

At recommended operating conditions (see Table 2).

Parameter	Symbol <sup>2</sup>	Min	Мах	Unit	Notes
JTAG external clock to output high impedance: Boundary-scan data TDO	t <sub>JTKLDZ</sub> t <sub>JTKLOZ</sub>	2 2	19 9	ns	5, 6

Notes:

1. All outputs are measured from the midpoint voltage of the falling/rising edge of  $t_{TCLK}$  to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50  $\Omega$  load (see Figure 18). Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.

2. The symbols for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t<sub>(first two letters of functional block)(reference)(state)(signal)(state)</sub> for outputs. For example, t<sub>JTDVKH</sub> symbolizes JTAG device timing (JT) with respect to the time data input signals (D) reaching the valid state (V) relative to the t<sub>JTG</sub> clock reference (K) going to the high (H) state or setup time. Also, t<sub>JTDXKH</sub> symbolizes JTAG timing (JT) with respect to the time data input signals (D) went invalid (X) relative to the t<sub>JTG</sub> clock reference (K) going to the high (H) state. In general, the clock reference symbol is based on three letters representing the clock of a particular function. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).</sub>

3. TRST is an asynchronous level sensitive signal. The setup time is for test purposes only.

4. Non-JTAG signal input timing with respect to t<sub>TCLK</sub>.

5. Non-JTAG signal output timing with respect to t<sub>TCLK</sub>.

6. Guaranteed by design and characterization.

Figure 27 provides the AC test load for TDO and the boundary-scan outputs of the MPC8347EA.



Figure 27. AC Test Load for the JTAG Interface

Figure 28 provides the JTAG clock input timing diagram.



Figure 28. JTAG Clock Input Timing Diagram

Figure 29 provides the  $\overline{\text{TRST}}$  timing diagram.





## Table 45. PCI AC Timing Specifications at 66 MHz<sup>1</sup> (continued)

Parameter	Symbol <sup>2</sup>	Min	Max	Unit	Notes
Input hold from clock	t <sub>PCIXKH</sub>	0	_	ns	3, 5

Notes:

- 1. PCI timing depends on M66EN and the ratio between PCI1/PCI2. Refer to the PCI chapter of the reference manual for a description of M66EN.
- 2. The symbols for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>PCIVKH</sub> symbolizes PCI timing (PC) with respect to the time the input signals (I) reach the valid state (V) relative to the PCI\_SYNC\_IN clock, t<sub>SYS</sub>, reference (K) going to the high (H) state or setup time. Also, t<sub>PCRHFV</sub> symbolizes PCI timing (PC) with respect to the time hard reset (R) went high (H) relative to the frame signal (F) going to the valid (V) state.</sub>
- 3. See the timing measurement conditions in the PCI 2.3 Local Bus Specifications.
- 4. For active/float timing measurements, the Hi-Z or off-state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
- 5. Input timings are measured at the pin.

## Table 46 provides the PCI AC timing specifications at 33 MHz.

## Table 46. PCI AC Timing Specifications at 33 MHz

Parameter	Symbol <sup>1</sup>	Min	Мах	Unit	Notes
Clock to output valid	<sup>t</sup> PCKHOV	—	11	ns	2
Output hold from clock	t <sub>PCKHOX</sub>	2	—	ns	2
Clock to output high impedance	t <sub>PCKHOZ</sub>	—	14	ns	2, 3
Input setup to clock	t <sub>PCIVKH</sub>	3.0	—	ns	2, 4
Input hold from clock	t <sub>PCIXKH</sub>	0	_	ns	2, 4

Notes:

- The symbols for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t<sub>(first two letters of functional block)(reference)(state)(signal)(state)</sub> for outputs. For example, t<sub>PCIVKH</sub> symbolizes PCI timing (PC) with respect to the time the input signals (I) reach the valid state (V) relative to the PCI\_SYNC\_IN clock, t<sub>SYS</sub>, reference (K) going to the high (H) state or setup time. Also, t<sub>PCRHFV</sub> symbolizes PCI timing (PC) with respect to the time hard reset (R) went high (H) relative to the frame signal (F) going to the valid (V) state.
  </sub>
- 2. See the timing measurement conditions in the PCI 2.3 Local Bus Specifications.
- 3. For active/float timing measurements, the Hi-Z or off-state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
- 4. Input timings are measured at the pin.

Figure 34 provides the AC test load for PCI.



MPC8347EA PowerQUICC II Pro Integrated Host Processor Hardware Specifications, Rev. 12



Pitch Module height (typical) Solder balls

Ball diameter (typical)

1.00 mm 1.46 mm 62 Sn/36 Pb/2 Ag (ZU package) 96.5 Sn/3.5Ag (VV package) 0.64 mm





## 18.3 Package Parameters for the MPC8347EA PBGA

The package parameters are as provided in the following list. The package type is  $29 \text{ mm} \times 29 \text{ mm}$ , 620 plastic ball grid array (PBGA).

Package outline	29 mm × 29 mm
Interconnects	620
Pitch	1.00 mm
Module height (maximum)	2.46 mm
Module height (typical)	2.23 mm
Module height (minimum)	2.00 mm
Solder balls	62 Sn/36 Pb/2 Ag (ZQ package)
	96.5 Sn/3.5Ag (VR package)
Ball diameter (typical)	0.60 mm



## 18.5 Pinout Listings

Table 55 provides the pinout listing for the MPC8347EA, 672 TBGA package.

## Table 55. MPC8347EA (TBGA) Pinout Listing

Signal	Package Pin Number		Power Supply	Notes
	PCI			
PCI_INTA/IRQ_OUT	B34	0	OV <sub>DD</sub>	2
PCI_RESET_OUT	C33	0	OV <sub>DD</sub>	—
PCI_AD[31:0]	G30, G32, G34, H31, H32, H33, H34, J29, J32, J33, L30, K31, K33, K34, L33, L34, P34, R29, R30, R33, R34, T31, T32, T33, U31, U34, V31, V32, V33, V34, W33, W34	I/O	OV <sub>DD</sub>	_
PCI_C/BE[3:0]	J30, M31, P33, T34	I/O	OV <sub>DD</sub>	—
PCI_PAR	P32	I/O	OV <sub>DD</sub>	—
PCI_FRAME	M32	I/O	OV <sub>DD</sub>	5
PCI_TRDY	N29	I/O	OV <sub>DD</sub>	5
PCI_IRDY	M34	I/O	OV <sub>DD</sub>	5
PCI_STOP	N31	I/O	OV <sub>DD</sub>	5
PCI_DEVSEL	N30	I/O	OV <sub>DD</sub>	5
PCI_IDSEL	J31	I	OV <sub>DD</sub>	—
PCI_SERR	N34	I/O	OV <sub>DD</sub>	5
PCI_PERR	N33	I/O	OV <sub>DD</sub>	5
PCI_REQ[0]	D32	I/O	OV <sub>DD</sub>	—
PCI_REQ[1]/CPCI1_HS_ES	D34	I	OV <sub>DD</sub>	—
PCI_REQ[2:4]	E34, F32, G29	I	OV <sub>DD</sub>	—
PCI_GNT0	C34	I/O	OV <sub>DD</sub>	—
PCI_GNT1/CPCI1_HS_LED	D33	0	OV <sub>DD</sub>	—
PCI_GNT2/CPCI1_HS_ENUM	E33	0	OV <sub>DD</sub>	—
PCI_GNT[3:4]	F31, F33	0	OV <sub>DD</sub>	—
M66EN	A19	I	OV <sub>DD</sub>	—
	DDR SDRAM Memory Interface			
MDQ[0:63]	D5, A3, C3, D3, C4, B3, C2, D4, D2, E5, G2, H6, E4, F3, G4, G3, H1, J2, L6, M6, H2, K6, L2, M4, N2, P4, R2, T4, P6, P3, R1, T2, AB5, AA3, AD6, AE4, AB4, AC2, AD3, AE6, AE3, AG4, AK5, AK4, AE2, AG6, AK3, AK2, AL2, AL1, AM5, AP5, AM2, AN1, AP4, AN5, AJ7, AN7, AM8, AJ9, AP6, AL7, AL9, AN8	I/O	GV <sub>DD</sub>	



Table 55. MF COSTICA (TDOA) FITTOUL LISTING (Continued)	Table 55. MPC8347EA (	(TBGA)	Pinout L	isting	(continued)
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Signal	Package Pin Number	Pin Type	Power Supply	Notes		
Test						
TEST	D22	I	$OV_{DD}$	6		
TEST_SEL	AL13	I	OV <sub>DD</sub>	7		
	РМС					
QUIESCE	A18	0	$OV_{DD}$	_		
	System Control					
PORESET	C18	I	$OV_{DD}$	_		
HRESET	B18	I/O	$OV_{DD}$	1		
SRESET	D18	I/O	$OV_{DD}$	2		
	Thermal Management					
THERM0	K32	I	_	9		
	Power and Ground Signals					
AV <sub>DD</sub> 1	L31	Power for e300 PLL (1.2 V) nominal, 1.3 V for 667 MHz)	AV <sub>DD</sub> 1	_		
AV <sub>DD</sub> 2	AP12	Power for system PLL (1.2 V) nominal, 1.3 V for 667 MHz)	AV <sub>DD</sub> 2	_		
AV <sub>DD</sub> 3	AE1	Power for DDR DLL (1.2 V) nominal, 1.3 V for 667 MHz)	_			
AV <sub>DD</sub> 4	AJ13	Power for LBIU DLL (1.2 V) nominal, 1.3 V for 667 MHz)	AV <sub>DD</sub> 4			
GND	<ul> <li>A1, A34, C1, C7, C10, C11, C15, C23,</li> <li>C25, C28, D1, D8, D20, D30, E7, E13,</li> <li>E15, E17, E18, E21, E23, E25, E32,</li> <li>F6, F19, F27, F30, F34, G31, H5, J4,</li> <li>J34, K30, L5, M2, M5, M30, M33, N3,</li> <li>N5, P30, R5, R32, T5, T30, U6, U29,</li> <li>U33, V2, V5, V30, W6, W30, Y30,</li> <li>AA2, AA30, AB2, AB6, AB30, AC3,</li> <li>AC6, AD31, AE5, AF2, AF5, AF31,</li> <li>AG30, AG31, AH4, AJ3, AJ19, AJ22,</li> <li>AK7, AK13, AK14, AK16, AK18, AK20,</li> <li>AK25, AK28, AL3, AL5, AL10, AL12,</li> <li>AL22, AL27, AM1, AM6, AM7, AN12,</li> <li>AN17, AN34, AP1, AP8, AP34</li> </ul>		_			



## Table 56. MPC8347EA (PBGA) Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes		
PCI1_TRDY	A13	I/O	OV <sub>DD</sub>	5		
PCI1_IRDY	E13	I/O	OV <sub>DD</sub>	5		
PCI1_STOP	C13	I/O	OV <sub>DD</sub>	5		
PCI1_DEVSEL	B13	I/O	OV <sub>DD</sub>	5		
PCI1_IDSEL	C17	I	OV <sub>DD</sub>	—		
PCI1_SERR	C12	I/O	OV <sub>DD</sub>	5		
PCI1_PERR	B12	I/O	OV <sub>DD</sub>	5		
PCI1_REQ[0]	A21	I/O	OV <sub>DD</sub>			
PCI1_REQ[1]/CPCI1_HS_ES	C19	I	OV <sub>DD</sub>	—		
PCI1_REQ[2:4]	C18, A19, E20	I	OV <sub>DD</sub>	—		
PCI1_GNT0	B20	I/O	OV <sub>DD</sub>	—		
PCI1_GNT1/CPCI1_HS_LED	C20	0	OV <sub>DD</sub>	—		
PCI1_GNT2/CPCI1_HS_ENUM	B19	0	OV <sub>DD</sub>	—		
PCI1_GNT[3:4]	A20, E18	0	OV <sub>DD</sub>	—		
M66EN	L26	I	OV <sub>DD</sub>	—		
	DDR SDRAM Memory Interface					
MDQ[0:63]	AC25, AD27, AD25, AH27, AE28, AD26, AD24, AF27, AF25, AF28, AH24, AG26, AE25, AG25, AH26, AH25, AG22, AH22, AE21, AD19, AE22, AF23, AE19, AG20, AG19, AD17, AE16, AF16, AF18, AG18, AH17, AH16, AG9, AD12, AG7, AE8, AD11, AH9, AH8, AF6, AF8, AE6, AF1, AE4, AG8, AH3, AG3, AG4, AH2, AD7, AB4, AB3, AG1, AD5, AC2, AC1, AC4, AA3, Y4, AA4, AB1, AB2, Y5, Y3	I/O	GV <sub>DD</sub>			
MECC[0:4]/MSRCID[0:4]	AG13, AE14, AH12, AH10, AE15	I/O	GV <sub>DD</sub>	—		
MECC[5]/MDVAL	AH14	I/O	GV <sub>DD</sub>	—		
MECC[6:7]	AE13, AH11	I/O	GV <sub>DD</sub>	—		
MDM[0:8]	AG28, AG24, AF20, AG17, AE9, AH5, AD1, AA2, AG12	0	GV <sub>DD</sub>	—		
MDQS[0:8]	AE27, AE26, AE20, AH18, AG10, AF5, AC3, AA1, AH13	I/O	GV <sub>DD</sub>	—		
MBA[0:1]	AF10, AF11	0	GV <sub>DD</sub>	—		
MA[0:14]	AF13, AF15, AG16, AD16, AF17, AH20, AH19, AH21, AD18, AG21, AD13, AF21, AF22, AE1, AA5	0	GV <sub>DD</sub>	—		
MWE	AD10	0	GV <sub>DD</sub>	—		



Table 50. MFC6547EA (FBGA) Fillout Listing (continued	Table 56. MPC8347F	EA (PBGA) F	Pinout Listing	(continued)
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Signal	Package Pin Number	Pin Type	Power Supply	Notes			
MPH1_PCTL0/DR_TX_VALID_PCTL0	A26	0	OV <sub>DD</sub>	_			
MPH1_PCTL1/DR_TX_VALIDH_PCTL1	B25	0	OV <sub>DD</sub>				
MPH1_CLK/DR_CLK	A25	I	OV <sub>DD</sub>	_			
	USB Port 0						
MPH0_D0_ENABLEN/DR_D8_CHGVBUS	D24	I/O	OV <sub>DD</sub>	_			
MPH0_D1_SER_TXD/DR_D9_DCHGVBUS	C24	I/O	OV <sub>DD</sub>	—			
MPH0_D2_VMO_SE0/DR_D10_DPPD	B24	I/O	OV <sub>DD</sub>	—			
MPH0_D3_SPEED/DR_D11_DMMD	A24	I/O	OV <sub>DD</sub>	—			
MPH0_D4_DP/DR_D12_VBUS_VLD	D23	I/O	OV <sub>DD</sub>	—			
MPH0_D5_DM/DR_D13_SESS_END	C23	I/O	OV <sub>DD</sub>	—			
MPH0_D6_SER_RCV/DR_D14	B23	I/O	OV <sub>DD</sub>	_			
MPH0_D7_DRVVBUS/DR_D15_IDPULLUP	A23	I/O	OV <sub>DD</sub>	—			
MPH0_NXT/DR_RX_ACTIVE_ID	D22	I	OV <sub>DD</sub>	_			
MPH0_DIR_DPPULLUP/DR_RESET	C22	I/O	OV <sub>DD</sub>	—			
MPH0_STP_SUSPEND/DR_TX_READY	B22	I/O	OV <sub>DD</sub>	—			
MPH0_PWRFAULT/DR_RX_VALIDH	A22	I	OV <sub>DD</sub>	_			
MPH0_PCTL0/DR_LINE_STATE0	E21	I/O	OV <sub>DD</sub>	—			
MPH0_PCTL1/DR_LINE_STATE1	D21	I/O	OV <sub>DD</sub>	—			
MPH0_CLK/DR_RX_VALID	C21	I	OV <sub>DD</sub>	_			
Pi	Programmable Interrupt Controller						
MCP_OUT	E8	0	OV <sub>DD</sub>	2			
IRQ0/MCP_IN/GPIO2[12]	J28	I/O	OV <sub>DD</sub>	—			
IRQ[1:5]/GPIO2[13:17]	K25, J25, H26, L24, G27	I/O	OV <sub>DD</sub>	—			
IRQ[6]/GPIO2[18]/CKSTOP_OUT	G28	I/O	OV <sub>DD</sub>	—			
IRQ[7]/GPIO2[19]/CKSTOP_IN	J26	I/O	OV <sub>DD</sub>	—			
	Ethernet Management Interface						
EC_MDC	Y24	0	LV <sub>DD1</sub>	—			
EC_MDIO	Y25	I/O	LV <sub>DD1</sub>	11			
	Gigabit Reference Clock						
EC_GTX_CLK125	Y26	I	LV <sub>DD1</sub>	_			
Three-Spee	ed Ethernet Controller (Gigabit Ethern	et 1)					
TSEC1_COL/GPIO2[20]	M26	I/O	OV <sub>DD</sub>	_			
TSEC1_CRS/GPIO2[21]	U25	I/O	LV <sub>DD1</sub>	—			
TSEC1_GTX_CLK	V24	0	LV <sub>DD1</sub>	3			



Signal	Package Pin Number	Pin Type	Power Supply	Notes	
Thermal Management					
THERM0	B15	I	_	8	
	Power and Ground Signals				
AV <sub>DD</sub> 1	C15	Power for e300 PLL (1.2 V) nominal, 1.3 V for 667 MHz)	AV <sub>DD</sub> 1		
AV <sub>DD</sub> 2	U1	Power for system PLL (1.2 V) nominal, 1.3 V for 667 MHz)	AV <sub>DD</sub> 2		
AV <sub>DD</sub> 3	AF9	Power for DDR DLL (1.2 V nominal, 1.3 V for 667 MHz)			
AV <sub>DD</sub> 4	U2	Power for LBIU DLL (1.2 V nominal, 1.3 V for 667 MHz)	AV <sub>DD</sub> 4		
GND	A2, B1, B2, D10, D18, E6, E14, E22, F9, F12, F15, F18, F21, F24, G5, H6, J23, L4, L6, L12, L13, L14, L15, L16, L17, M11, M12, M13, M14, M15, M16, M17, M18, M23, N11, N12, N13, N14, N15, N16, N17, N18, P6, P11, P12, P13, P14, P15, P16, P17, P18, P24, R5, R11, R12, R13, R14, R15, R16, R17, R18, R23, T11, T12, T13, T14, T15, T16, T17, T18, U6, U11, U12, U13, U14, U15, U16, U17, U18, V12, V13, V14, V15, V16, V17, V23, V25, W4, Y6, AA23, AB24, AC5, AC8, AC11, AC14, AC17, AC20, AD9, AD15, AD21, AE12, AE18, AF3, AF26				
GV <sub>DD</sub>	U9, V9, W10, W19, Y11, Y12, Y14, Y15, Y17, Y18, AA6, AB5, AC9, AC12, AC15, AC18, AC21, AC24, AD6, AD8, AD14, AD20, AE5, AE11, AE17, AG2, AG27	Power for DDR DRAM I/O voltage (2.5 V)	GV <sub>DD</sub>		



Signal	Package Pin Number	Pin Type	Power Supply	Notes
LV <sub>DD</sub> 1	U20, W25	Power for three-speed Ethernet #1 and for Ethernet management interface I/O (2.5 V, 3.3 V)	LV <sub>DD</sub> 1	_
LV <sub>DD</sub> 2	V20, Y23	Power for three-speed Ethernet #2 I/O (2.5 V, 3.3 V)	LV <sub>DD</sub> 2	_
V <sub>DD</sub>	J11, J12, J15, K10, K11, K12, K13, K14, K15, K16, K17, K18, K19, L10, L11, L18, L19, M10, M19, N10, N19, P9, P10, P19, R10, R19, R20, T10, T19, U10, U19, V10, V11, V18, V19, W11, W12, W13, W14, W15, W16, W17, W18	Power for core (1.2 V)	V <sub>DD</sub>	_
OV <sub>DD</sub>	B27, D3, D11, D19, E15, E23, F5, F8, F11, F14, F17, F20, G24, H23, H24, J6, J14, J17, J18, K4, L9, L20, L23, L25, M6, M9, M20, P5, P20, P23, R6, R9, R24, U23, V4, V6	PCI, 10/100 Ethernet, and other standard (3.3 V)	OV <sub>DD</sub>	_
MVREF1	AF19	I	DDR reference voltage	_
MVREF2	AE10	I	DDR reference voltage	—
	No Connection			
NC	V1, V2, V5		_	

## Table 56. MPC8347EA (PBGA) Pinout Listing (continued)

#### Notes:

1. This pin is an open-drain signal. A weak pull-up resistor (1 k $\Omega$ ) should be placed on this pin to OV<sub>DD</sub>.

- 2. This pin is an open-drain signal. A weak pull-up resistor (2-10 kΩ) should be placed on this pin to OV<sub>DD</sub>.
- 3. During reset, this output is actively driven rather than three-stated.
- 4. These JTAG pins have weak internal pull-up P-FETs that are always enabled.
- 5. This pin should have a weak pull-up if the chip is in PCI host mode. Follow the PCI specifications.

6. This pin must always be tied to GND.

- 7. This pin must always be left not connected.
- 8. Thermal sensitive resistor.

9. It is recommended that MDIC0 be tied to GRD using an 18  $\Omega$  resistor and MDIC1 be tied to DDR power using an 18  $\Omega$  resistor.

- 10.TSEC1\_TXD[3] is required an external pull-up resistor. For proper functionality of the device, this pin must be pulled up or actively driven high during a hard reset. No external pull-down resistors are allowed to be attached to this net.
- 11. A weak pull-up resistor (2–10 k $\Omega$ ) should be placed on this pin to LV<sub>DD1</sub>.
- 12. For systems that boot from local bus (GPCM)-controlled NOR flash, a pullup on LGPL4 is required.



As shown in Figure 42, the primary clock input (frequency) is multiplied up by the system phase-locked loop (PLL) and the clock unit to create the coherent system bus clock ( $csb\_clk$ ), the internal clock for the DDR controller ( $ddr\_clk$ ), and the internal clock for the local bus interface unit ( $lbiu\_clk$ ).

The *csb\_clk* frequency is derived from a complex set of factors that can be simplified into the following equation:

 $csb\_clk = \{PCI\_SYNC\_IN \times (1 + CFG\_CLKIN\_DIV)\} \times SPMF$ 

In PCI host mode, PCI\_SYNC\_IN  $\times$  (1 + CFG\_CLKIN\_DIV) is the CLKIN frequency.

The *csb\_clk* serves as the clock input to the e300 core. A second PLL inside the e300 core multiplies the *csb\_clk* frequency to create the internal clock for the e300 core (*core\_clk*). The system and core PLL multipliers are selected by the SPMF and COREPLL fields in the reset configuration word low (RCWL), which is loaded at power-on reset or by one of the hard-coded reset options. See the chapter on reset, clocking, and initialization in the *MPC8349EA Reference Manual* for more information on the clock subsystem.

The internal *ddr\_clk* frequency is determined by the following equation:

 $ddr_clk = csb_clk \times (1 + RCWL[DDRCM])$ 

 $ddr_clk$  is not the external memory bus frequency;  $ddr_clk$  passes through the DDR clock divider (÷2) to create the differential DDR memory bus clock outputs (MCK and MCK). However, the data rate is the same frequency as  $ddr_clk$ .

The internal *lbiu\_clk* frequency is determined by the following equation:

 $lbiu_clk = csb_clk \times (1 + \text{RCWL[LBIUCM]})$ 

*lbiu\_clk* is not the external local bus frequency; *lbiu\_clk* passes through the LBIU clock divider to create the external local bus clock outputs (LSYNC\_OUT and LCLK[0:2]). The LBIU clock divider ratio is controlled by LCCR[CLKDIV].

In addition, some of the internal units may have to be shut off or operate at lower frequency than the *csb\_clk* frequency. Those units have a default clock ratio that can be configured by a memory-mapped register after the device exits reset. Table 57 specifies which units have a configurable clock frequency.

Unit	Default Frequency	Options
TSEC1	csb_clk/3	Off, csb_clk, csb_clk/2, csb_clk/3
TSEC2, I <sup>2</sup> C1	csb_clk/3	Off, csb_clk, csb_clk/2, csb_clk/3
Security core	csb_clk/3	Off, csb_clk, csb_clk/2, csb_clk/3
USB DR, USB MPH	csb_clk/3	Off, csb_clk, csb_clk/2, <i>csb_clk/3</i>
PCI and DMA complex	csb_clk	Off, csb_clk

Table 57	. Configurable	<b>Clock Units</b>
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Table 58 provides the operating frequencies for the MPC8347EA TBGA under recommended operating conditions (see Table 2). All frequency combinations shown in the table below may not be available. Maximum operating frequencies depend on the part ordered, see Section 22.1, "Part Numbers Fully



## Table 65. Package Thermal Characteristics for TBGA (continued)

Characteristic	Symbol	Value	Unit	Notes
Junction-to-package natural convection on top	ΨJT	1	°C/W	6

#### Notes:

- 1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
- 2. Per SEMI G38-87 and JEDEC JESD51-2 with the single-layer board horizontal.
- 3. Per JEDEC JESD51-6 with the board horizontal, 1 m/s is approximately equal to 200 linear feet per minute (LFM).
- 4. Thermal resistance between the die and the printed-circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
- 5. Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).
- 6. Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

Table 66 provides the package thermal characteristics for the  $62029 \times 29$  mm PBGA of the MPC8347EA.

Parameter	Symbol	Value	Unit	Notes
Junction-to-ambient natural convection on single-layer board (1s)	$R_{ ext{ heta}JA}$	21	°C/W	1, 2
Junction-to-ambient natural convection on four-layer board (2s2p)	R <sub>0JMA</sub>	15	°C/W	1, 3
Junction-to-ambient (at 200 ft/min) on single-layer board (1s)	$R_{ ext{ heta}JMA}$	17	°C/W	1, 3
Junction-to-ambient (at 200 ft/min) on four-layer board (2s2p)	R <sub>0JMA</sub>	12	°C/W	1, 3
Junction-to-board thermal	$R_{ ext{ heta}JB}$	6	°C/W	4
Junction-to-case thermal	$R_{ ext{ heta}JC}$	5	°C/W	5
Junction-to-package natural convection on top	ΨJT	5	°C/W	6

### Notes

- 1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
- 2. Per SEMI G38-87 and JEDEC JESD51-2 with the single-layer board horizontal.
- 3. Per JEDEC JESD51-6 with the board horizontal.
- 4. Thermal resistance between the die and the printed-circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
- 5. Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).
- 6. Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

## 20.2 Thermal Management Information

For the following sections,  $P_D = (V_{DD} \times I_{DD}) + P_{I/O}$  where  $P_{I/O}$  is the power dissipation of the I/O drivers. See Table 5 for I/O power dissipation values.





parts including extended temperatures, refer to the device product summary page on our website listed on the back cover of this document or, contact your local Freescale sales office.

MPC	nnnn	е	t	рр	aa	а	r
Product Code	Part Identifier	Encryption Acceleration	Temperature <sup>1</sup> Range	Package <sup>2</sup>	Processor Frequency <sup>3</sup>	Platform Frequency	Revision Level
MPC	8347	Blank = Not included E = included	Blank = 0 to 105°C C = -40 to 105°C	ZU =TBGA VV = PB free TBGA ZQ = PBGA VR = PB Free PBGA	e300 core speed AD = 266 AG = 400 AJ = 533 AL = 667	D = 266 F = 333 <sup>4</sup>	B = 3.1

## Table 70. Part Numbering Nomenclature

#### Notes:

1. For temperature range = C, processor frequency is limited to 400 (PBGA) with a platform frequency of 266 and up to 533 (TBGA) with a platform frequency of 333

2. See Section 18, "Package and Pin Listings," for more information on available package types.

 Processor core frequencies supported by parts addressed by this specification only. Not all parts described in this specification support all core frequencies. Additionally, parts addressed by Part Number Specifications may support other maximum core frequencies.

4. ALF marked parts support DDR1 data rate up to 333 MHz (at 333 MHz CSB as the 'F' marking implies) and DDR2 data rate up to 400 MHz (at 200 MHz CSB). AJF marked parts support DDR1 and DDR2 data rate up to 333 MHz (at a CSB of 333 MHz).

Table 71 shows the SVR settings by device and package type.

## Table 71. SVR Settings

Device	Package	SVR (Rev. 3.0)
MPC8347EA	TBGA	8052_0030
MPC8347A	TBGA	8053_0030
MPC8347EA	PBGA	8054_0030
MPC8347A	PBGA	8055_0030

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